

TÜV MANAGEMENT SERVICE



An ISO/TS 16949, ISO 9001 and ISO 14001 Certified Company

PNP SILICON PLANAR SWITCHING TRANSISTORS

2N2906 2N2907

TO-18 Metal (

Metal Can Package



Switching and Linear Application

ABSOLUTE MAXIMUM RATINGS

DESCRIPTION	SYMBOL	VALUE	UNIT
Collector Emitter Voltage	V_{CEO}	40	V
Collector Base Voltage	V_{CBO}	60	V
Emitter Base Voltage	V_{EBO}	5	V
Collector Current Continuous	I _C	600	mA
Power Dissipation @ T _a =25°C	P_{D}	400	mW
Derate Above 25°C		2.28	mW/ °C
Power Dissipation @ T _c =25°C	P_{D}	1.8	W
Derate Above 25°C		10.3	mW/ °C
Operating and Storage Junction Temperature Range	T_j , T_{stg}	- 65 to +200	°C

ELECTRICAL CHARACTERISTICS (T_a=25°C unless specified otherwise)

DESCRIPTION	SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNIT
Collector Emitter Voltage	*V _{CEO}	$I_C=10$ mA, $I_B=0$	40			V
Collector Base Voltage	V_{CBO}	$I_{C}=10\mu A, I_{E}=0$	60			V
Emitter Base Voltage	V_{EBO}	$I_{E}=10\mu A, I_{C}=0$	5			V
Collector Cut Off Current	I _{CEX}	$V_{CE} = 30V, V_{BE} = 0.5V$			50	nA
Collector Cut Off Current	I _{CBO}	$V_{CB}=50V$, $I_{E}=0$			20	nA
		V_{CB} =50V, I_{E} =0, T_{a} =150°C			20	μΑ
Base Current	I _B	$V_{CE} = 30V, V_{BE} = 0.5V$			50	nA

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DC Current Gain	h _{FE}	I _C =0.1mA, V _{CE} =10V	>20	>35	
		I _C =1mA, V _{CE} =10V	>25	>50	
		$I_C=10$ mA, $V_{CE}=10$ V	>35	>75	
		*I _C =150mA, V _{CE} =10V	40 - 120	100 - 300	
		*I _C =500mA, V _{CE} =10V	>20	>30	

*Pulse Test: Pulse Width ≤ 300ms, Duty Cycle ≤ 2%



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ELECTRICAL CHARACTERISTICS (T_a =25°C unless specified otherwise)

SMALL SIGNAL CHARACTERISTICS

DESCRIPTION	SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNIT
Collector Emitter Saturation Voltage	*V _{CE (sat)}	$I_C=150$ mA, $I_B=15$ mA			0.4	V
		$I_C=500$ mA, $I_B=50$ mA			1.6	V
Base Emitter Saturation Voltage	*V _{BE (sat)}	$I_C=150$ mA, $I_B=15$ mA			1.3	V
		I_C =500mA, I_B =50mA			2.6	V
Transition Frequency	**f _T	I _C =50mA, V _{CE} =20V, f=100MHz	200			MHz
Output Capacitance	C _{obo}	V _{CB} =10V, I _E =0, f=100KHz			8.0	pF
	C _{ibo}	V _{BE} =2V, I _C =0, f=100KHz			30	pF

SWITCHING TIME

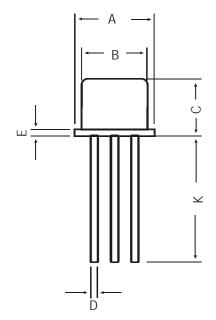
OWNE						
DESCRIPTION	SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNIT
Delay Time	t _d	_150m			10	ns
Rise Time	t _r	V _{CC} =30V			40	ns
Turn On Time	t _{on}				45	ns
Storage Time	ts	1 450 4 1			80	ns
Fall Time	t _f	I _C =150mA, I _{B1} = I _{B2} =15mA, V _{CC} =6V			30	ns
Turn Off Time	t _{off}	182-1011/A, V CC-0 V			100	ns

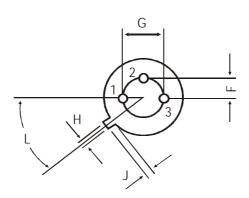
^{*}Pulse Test: Pulse Width ≤ 300ms, Duty Cycle ≤ 2%

^{**} f_T is defined as the frequency at which Ih_{fe}I extrapolates to unity

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DIM	MIN	MAX			
Α	5.24	5.84			
В	4.52	4.97			
С	4.31	5.33			
D	0.40	0.53			
E		0.76			
F		1.27			
G	ı	2.97			
Н	0.91	1.17			
J	0.71	1.21			
K	12.70	_			
L	45 DEG				
	A B C D E F G H J K	A 5.24 B 4.52 C 4.31 D 0.40 E — F — G — H 0.91 J 0.71 K 12.70			



PIN CONFIGURATION

- 1. EMITTER
- 2. BASE3. COLLECTOR

Packing Detail

PACKAGE	STANDARD PACK		INNER CARTON BOX		OUTER CARTON BOX		
	Details	Net Weight/Qty	Size	Qty	Size Qty Gr V		
TO-18	1K/polybag	350 gm/1K pcs	3" x 7.5" x 7.5"	5K	17" x 15" x 13.5"	80K	34 kgs

Customer Notes 2N2906 2N2907

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Disclaimer

The product information and the selection guides facilitate selection of the CDIL's Discrete Semiconductor Device(s) best suited for application in your product(s) as per your requirement. It is recommended that you completely review our Data Sheet(s) so as to confirm that the Device(s) meet functionality parameters for your application. The information furnished in the Data Sheet and on the CDIL Web Site/CD are believed to be accurate and reliable. CDIL however, does not assume responsibility for inaccuracies or incomplete information. Furthermore, CDIL does not assume liability whatsoever, arising out of the application or use of any CDIL product; neither does it convey any license under its patent rights nor rights of others. These products are not designed for use in life saving/support appliances or systems. CDIL customers selling these products (either as individual Discrete Semiconductor Devices or incorporated in their end products), in any life saving/support appliances or systems or applications do so at their own risk and CDIL will not be responsible for any damages resulting from such sale(s).

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